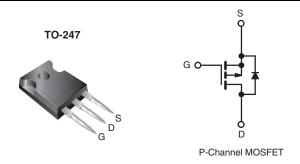


Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	- 200 V			
R _{DS(on)} (Max.) (Ω)	V _{GS} = - 10 V	0.50		
Q _g (Max.) (nC)	44			
Q _{gs} (nC)	7.1			
Q _{gd} (nC)	27			
Configuration	Single			



FEATURES

- · Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- P-Channel
- · Isolated Central Mounting Hole
- · Fast Switching
- · Ease of Paralleling
- · Simple Drive Requirements
- · Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mounting hole. It also provides greater creepage distance between pins to meet the requirements of most safety specifications.

ORDERING INFORMATION	
Package	TO-247
Lead (Pb)-free	IRFP9240PbF
	SiHFP9240-E3
SnPb	IRFP9240
	SiHFP9240

ABSOLUTE MAXIMUM RATINGS T	$_{\rm C}$ = 25 $^{\circ}$ C, unless otherw	ise noted		_	
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V_{DS}	- 200	V	
Gate-Source Voltage		V_{GS}	± 20	V	
Continuous Drain Current	V_{GS} at - 10 V $T_{C} = 25 ^{\circ}C$ $T_{C} = 100 ^{\circ}C$	- I _D	- 12		
	$T_C = 100 ^{\circ}C$		- 7.5	Α	
Pulsed Drain Current ^a	I _{DM}	- 48			
Linear Derating Factor			1.2	W/°C	
Single Pulse Avalanche Energy ^b		E _{AS}	790	mJ	
Repetitive Avalanche Currenta		I _{AR}	- 12	Α	
Repetitive Avalanche Energy ^a		E _{AR}	15	mJ	
Maximum Power Dissipation	T _C = 25 °C	P_{D}	150	W	
Peak Diode Recovery dV/dt ^c		dV/dt	- 5.0	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d		
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 of M3 screw		1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. V_{DD} = -50 V, starting T_J = 25 °C, L = 8.2 mH, R_G = 25 Ω , I_{AS} = -12 A (see fig. 12).
- c. $I_{SD} \le -12$ A, $dI/dt \le 150$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	=	40	
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.83	

SPECIFICATIONS $T_J = 25 ^{\circ}C$,	unless other	wise noted					
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							,
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = - 1 mA	-	- 0.20	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	V _{GS} , I _D = - 250 μA	- 2.0	-	- 4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current		V _{DS} =	V _{DS} = - 200 V, V _{GS} = 0 V		-	- 100	
Zero date voltage Drain Current	I _{DSS}	V _{DS} = - 160 '	V, V _{GS} = 0 V, T _J = 125 °C	ı	-	- 500	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 7.2 A ^b	-	-	0.50	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	- 50 V, I _D = - 7.2 A	4.2	-	-	S
Dynamic							
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,		1200	-	
Output Capacitance	Coss		V _{DS} = - 25 V,	1	370	-	pF
Reverse Transfer Capacitance	C_{rss}	t = 1	.0 MHz, see fig. 5	1	81	-	
Total Gate Charge	Q_g		I _D = - 11 A, V _{DS} = - 160 V see fig. 6 and 13 ^b	-	-	44	nC
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V		-	-	7.1	
Gate-Drain Charge	Q _{gd}			-	-	27	
Turn-On Delay Time	t _{d(on)}			-	14	-	
Rise Time	t _r	V_{DD} = - 100 V, I_{D} = - 11 A R_{G} = 9.1 Ω, R_{D} = 8.6 Ω, see fig. 10 ^b		-	43	-	- ns
Turn-Off Delay Time	t _{d(off)}			-	39	-	
Fall Time	t _f			-	38	-	
Internal Drain Inductance	L_D	6 mm (0.25")	Between lead, 6 mm (0.25") from		5.0	-	
Internal Source Inductance	L _S	package and center of die contact		-	13	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET sym	MOSFET symbol showing the		-	- 12	- A
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	- 48	
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = - 12 A, V _{GS} = 0 V ^b		-	-	- 5.0	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = - 11 A, dl/dt = 100 A/μs ^b		-	250	300	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	2.9	3.6	μС
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L			_D)		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

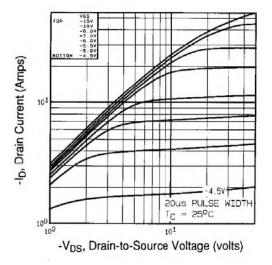


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

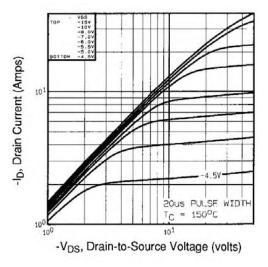


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

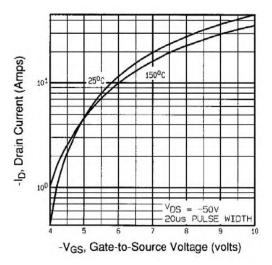


Fig. 3 - Typical Transfer Characteristics

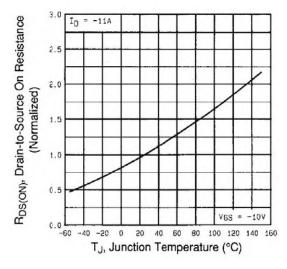


Fig. 4 - Normalized On-Resistance vs. Temperature



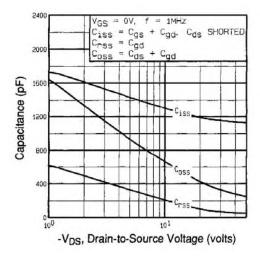


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

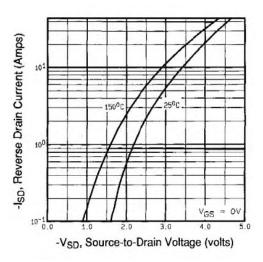


Fig. 7 - Typical Source-Drain Diode Forward Voltage

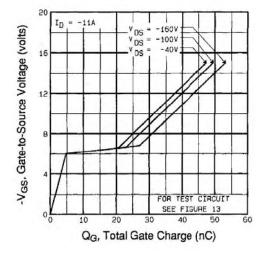


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

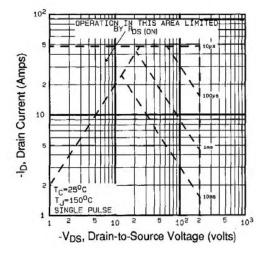


Fig. 8 - Maximum Safe Operating Area



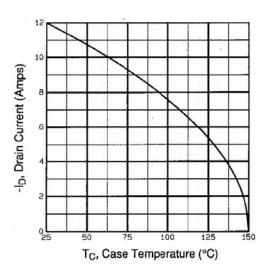


Fig. 9 - Maximum Drain Current vs. Case Temperature

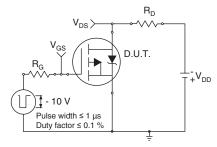


Fig. 10a - Switching Time Test Circuit

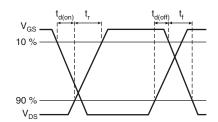


Fig. 10b - Switching Time Waveforms

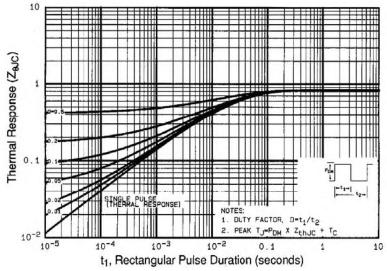


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



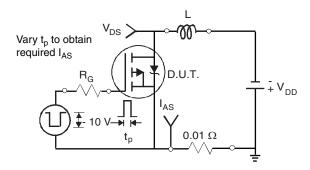


Fig. 12a - Unclamped Inductive Test Circuit

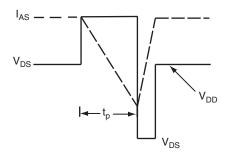


Fig. 12b - Unclamped Inductive Waveforms

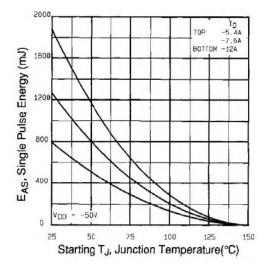


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

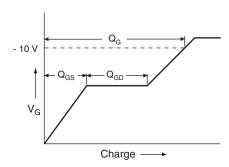


Fig. 13a - Basic Gate Charge Waveform

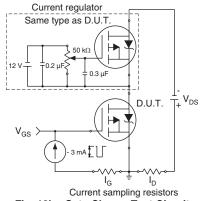
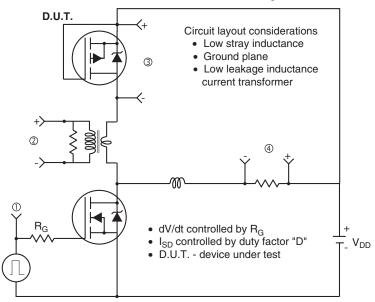


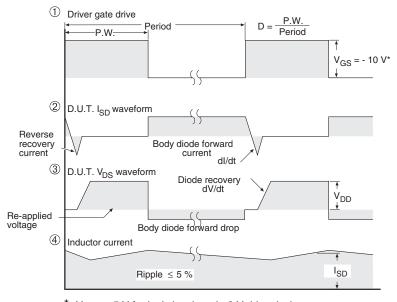
Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver



 $V_{GS} = -5 \text{ V for logic level and } -3 \text{ V drive devices}$

Fig. 14 - For P-Channel

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